## INTEGRATED CIRCUITS

# DATA SHEET

## **FBL2033**

3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

Product specification

1999 Apr 15

IC23 data handbook

## **Philips Semiconductors**





## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

#### **FEATURES**

- 8-bit transceivers
- Latched, registered or straight through in either A to B or B to A path
- Drives heavily loaded backplanes with equivalent load impedances down to 10Ω.
- High drive 100mA BTL Open Collector drivers on B-port
- Allows incident wave switching in heavily loaded backplane buses
- Reduced BTL voltage swing produces less noise and reduces power consumption
- Built-in precision band-gap reference provides accurate receiver thresholds and improved noise immunity

- Compatible with IEEE Futurebus+ or proprietary BTL backplanes
- Each BTL driver has a dedicated Bus GND for a signal return
- Controlled output ramp and multiple GND pins minimize ground bounce
- Glitch-free power up/power down operation
- Low I<sub>CC</sub> current
- Tight output skew
- Supports live insertion
- Pins for the optional JTAG boundary scan function are provided
- High density packaging in plastic Quad Flatpack
- 5V compatible I/O on A-port

#### **QUICK REFERENCE DATA**

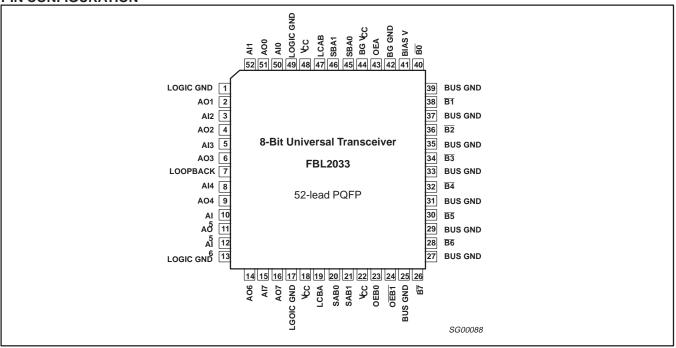
SYMBOL	PARAM	ETER	TYPICAL	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay Aln to Bn	3.0 3.0	ns	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay Bn to AOn	5.0 5.3	ns	
C <sub>OB</sub>	Output capacitance (BO - Bn only)	6	pF	
I <sub>OL</sub>	Output current (B0 - Bn only)		100	mA
Icc	Supply current	Aln to Bn outputs Low outputs High	9 14	mA
	,	Bn to AOn (outputs Low)	17	]
		Bn to AOn (outputs High)	14	

### **ORDERING INFORMATION**

PACKAGE	COMMERCIAL RANGE $V_{CC} = 3.3V \pm 10\%$ ; $T_{amb} = -40$ °C to +85°C	DWG No.
52-pin Plastic Quad Flat Pack (PQFP)	FBL2033BB	SOT379-1

NOTE: Thermal mounting or forced air is recommended

### **PIN CONFIGURATION**



## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

#### DESCRIPTION

The FBL2033 is an 8-bit transceiver featuring a split input (AI) and output (AO) bus on the TTL-level side.

The common I/O, open collector B port operates at BTL signal levels. The logic element for data flow in each direction is controlled by two pairs of mode select inputs (SBA0 and SBA1 for B-to-A, SAB0 and SAB1 for A-to-B). It can be configured as a buffer, a register, or a D-type latch.

When configured in the buffer mode, the inverse of the input data appears at the output port. In the flip-flop mode, data is stored on the rising edge of the appropriate clock input (LCAB or LCBA). In the latch mode, clock pins serve as transparent-High latch enables. Regardless of the mode, data is inverted from input to output.

Data flow in the B-to-A direction, regardless of the logic element selected, is further controlled by the Loopback input. When the Loopback input is High the output of the selected A-to-B logic element (not inverted) becomes the B-to-A input.

The 3-State AO port is enabled by asserting a High level on OEA. The B port has two output enables, OEB0 and OEB1. Only when OEB0 is High and OEB1 is Low is the output enabled. When either OEB0 is Low or OEB1 is High, the B-port is inactive and is pulled to the level of the pull-up voltage. New data can be entered in the flip-flop and latched modes or can be retained while the associated outputs are in 3-State (AO port) or inactive (B port).

The B-port drivers are Low-capacitance open collectors with controlled ramp and are designed to sink 100mA. Precision band gap references on the B-port ensure very good noise margins by limiting the switching threshold to a narrow region centered at 1.55V.

The B-port interfaces to "Backplane Transceiver Logic" (see the IEEE 1194.1 BTL standard). BTL features low power consumption

by reducing voltage swing (1V p-p, between 1V and 2V) and reduced capacitive loading by placing an internal series diode on the drivers. BTL also provides incident wave switching, a necessity for high performance backplanes.

Output clamps are provided on the BTL outputs to further reduce switching noise. The " $V_{OH}$ " clamp reduces inductive ringing effects during a Low-to-High transition. The " $V_{OH}$ " clamp is always active. The other clamp, the "trapped reflection" clamp, clamps out ringing below the BTL 0.5V  $V_{OL}$  level. This clamp remains active for approximately 100ns after a High-to-Low transition.

To support live insertion, OEB0 is held Low during power on/off cycles to ensure glitch- free B port drivers. Proper bias for B port drivers during live insertion is provided by the BIAS V pin when at a 3.3V level while  $V_{CC}$  is Low. The BIAS V pin is a low current input which will reverse-bias the BTL driver series Schottky diode, and also bias the B port output pins to a voltage between 1.62V and 2.1V. This bias function is in accordance with IEEE BTL Standard 1194.1. If live insertion is not a requirement, the BIAS V pin should be tied to a  $V_{CC}$  pin.

The LOGIC GND and BUS GND pins are isolated inside the package to minimize noise coupling between the BTL and TTL sides. These pins should be tied to a common ground external to the package.

Each BTL driver has an associated BUS GND pin that acts as a signal return path and these BUS GND pins are internally isolated from each other. In the event of a ground return fault, a "hard" signal failure occurs instead of a pattern dependent error that may be very infrequent and impossible to trouble- shoot.

As with any high power device thermal considerations are critical. It is recommended that airflow (300lfpm) and/or thermal mounting be used to ensure proper junction temperature.

#### PIN DESCRIPTION

SYMBOL	PIN NUMBER	TYPE	NAME AND FUNCTION
AI0 – AI7	50, 52, 3, 5, 8, 10, 12, 15	Input	Data inputs (TTL)
AO0 – AO7	51, 2, 4, 6, 9, 11, 14, 16	Output	3-State outputs (TTL)
B0 – B7	40, 38, 36, 34, 32, 30, 28, 26	I/O	Data inputs/Open Collector outputs, High current drive (BTL)
OEB0	23	Input	Enables the B outputs when High
OEB1	24	Input	Enables the B outputs when Low
OEA	43	Input	Enables the AO outputs when High
BUS GND	39, 37, 35, 33, 31, 29, 27, 25	GND	Bus ground (0V)
LOGIC GND	1, 13, 17, 49	GND	Logic ground (0V)
V <sub>CC</sub>	18, 22, 48	Power	Positive supply voltage
BIAS V	41	Power	Live insertion pre-bias pin
BG V <sub>CC</sub>	44	Power	Band Gap threshold voltage reference
BG GND	42	GND	Band Gap threshold voltage reference ground
SABn	20, 21	Input	Mode select from AI to B
SBAn	45, 46	Input	Mode select from $\overline{B}$ to AO
LCAB	47	Input	A-to-B clock/latch enable (transparent latch when High)
LCBA	19	Input	B-to-A clock/latch enable (transparent latch when High)
Loopback	7	Input	Enables loopback function when High (from Aln to AOn)

1999 Apr 15 3

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

### **FUNCTION TABLE**

					INPUTS	3				OUTPUTS	
MODE	Aln	Bn*	OEB0	OEB1	OEA	LCAB	LCBA	SAB <sub>1</sub>	SBA <sub>1</sub>	AOn	Bn
Aln to Bn thru mode	L	_	Н	L	L	Х	Х	LL	XX	Z	H**
All to Bit tillu mode	Н	_	Н	L	L	Х	Х	LL	XX	Z	L
Aln to Bn transparent latch	L	_	Н	L	L	Н	Х	НХ	XX	Z	H**
All to bit transparent laten	Н	_	Н	L	L	Н	Х	HX	XX	Z	L
Alp to Re latch and road	I	_	Н	L	L	$\downarrow$	Х	НХ	XX	Z	H**
Aln to Bn latch and read	h	_	Н	L	L	$\downarrow$	Х	HX	XX	Z	L
Aln to Bn register	L	_	Н	L	L	1	Х	LH	XX	Z	H**
Am to Bit register	Н	_	Н	L	L	1	Х	LH	XX	Z	L
Bn outputs latched and read (preconditioned latch)	Х	_	Н	L	L	L	Х	НХ	XX	Z	latched data
Bn to AOn thru mode	Х	L	L	Н	Н	Х	Х	XX	LL	Н	input
Bir to Aoir tilla mode	Х	Н	L	Н	Н	Х	Х	XX	LL	L	input
Bn to AOn transparent latch	Х	L	L	Н	Н	Х	Н	XX	HX	Н	input
Bir to AOII transparent fatori	Х	Н	L	Н	Н	Х	Н	XX	НХ	L	input
Bn to AOn latch and read	Х	I	L	Н	Н	Х	$\downarrow$	XX	НХ	Н	input
Bir to Aoir lateir and read	Х	h	L	Н	Н	Х	$\downarrow$	XX	НХ	L	input
Bn to AOn register	Х	L	L	Н	Н	Х	1	XX	LH	Н	input
Bir to AOII register	Х	Н	L	Н	Н	Х	1	XX	LH	L	input
AOn outputs latched and read (preconditioned latch)	Х	Х	L	Н	Н	Х	L	XX	НХ	latched data	Х
Disable Bn outputs	Х	Х	L	Х	Х	Х	Х	XX	XX	Х	H**
Disable bil outputs	Х	Х	Х	Н	Х	Х	Х	XX	XX	Х	H**
Disable AOn outputs	Х	Х	Х	Х	L	Х	Х	XX	XX	Z	Х

### **FUNCTION SELECT TABLE**

MODE SELECTED	SXX1	SXX0
Thru mode	L	L
Register mode	L	Н
Latch mode	Н	Х

### NOTES:

H = High voltage level

L = Low voltage level

h = High voltage level one set-up time prior to the High-to-Low LCXX transition

Low voltage level one set-up time prior to the High-to-Low LCXX transition

X = Don't care

Z = High-impedance (OFF) state

— = Input not externally driven

= Low-to-High transition

= High-to-Low transition

H\*\* = Goes to level of pull-up voltage

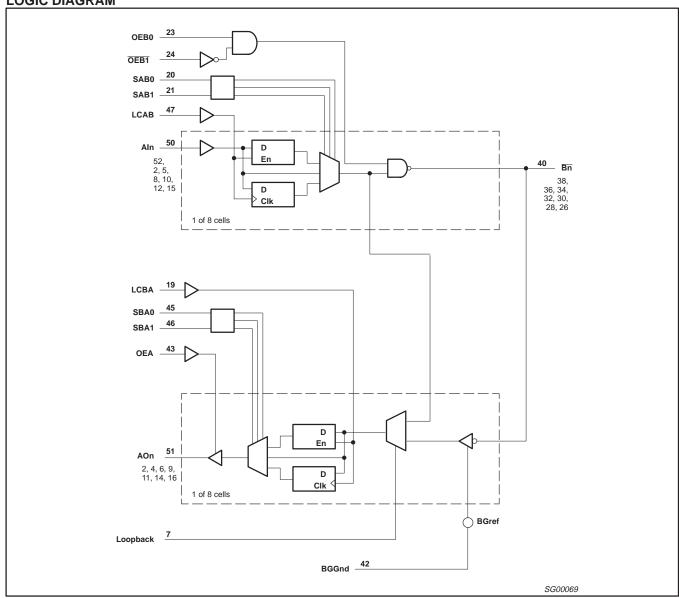
 $\overline{Bn}^*$  = Precaution should be taken to ensure B inputs do not float. If they do, they are equal to Low state.

In Loopback mode (Loopback = High), Aln inputs are routed to the AOn outputs. The  $\overline{\text{Bn}}$  inputs are blocked out.

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

### **LOGIC DIAGRAM**



## **ABSOLUTE MAXIMUM RATINGS**

Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.

SYMBOL	PARA	AMETER	RATING	UNIT	
V <sub>CC</sub>	Supply voltage	-0.5 to +4.6	V		
Visi	Input voltage	AI0 – AI7, OEB0, OEBn, OEAn	-0.5 to +7.0	V	
V <sub>IN</sub>	input voitage	B0 – B7	-0.5 to +3.5	]	
I <sub>IN</sub>	Input current	V <sub>IN</sub> < 0	-50	]	
V <sub>OUT</sub>	Voltage applied to output in High outp	out state	-0.5 to +7.0	V	
la	Current applied to output in	AO0 – AO7	64, –64	mA	
Гоит	Low output state/High output state	200	] '''		
T <sub>STG</sub>	Storage temperature	-65 to +150	°C		

1999 Apr 15 5

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

## **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER			COMMERCIAL LIMITS $V_{CC} = 3.3V\pm10\%;$ $T_{amb} = -40 \text{ to } +85^{\circ}\text{C}$			
			MIN	TYP	MAX		
V <sub>CC</sub>	Supply voltage		3.0	3.3	3.6	V	
V	High-level input voltage	Except B0-B7	2.0			V	
V <sub>IH</sub>	r light-level input voltage	B0 – B7	1.62	1.55		1	
	Low-level input voltage	Except B0-B7	1		0.8	V	
V <sub>IL</sub>		B0 – B7	1		1.47	1	
I <sub>IK</sub>	Input clamp current	•	1		-18	mA	
I <sub>OH</sub>	High-level output current	AO0 – AO7			-12	mA	
	Low lovel output ourrent	AO0 – AO7	1		+12	mA	
lol	Low-level output current	B0 – B7			100	1	
C <sub>OB</sub>	Output capacitance on B port	•	1	6	7	pF	
T <sub>amb</sub>	Operating free-air temperature range		0		+70	°C	

## LIVE INSERTION SPECIFICATIONS

SYMBOL		PARAMETER		LIMITS					
STWIBUL		MIN	TYP	MAX	UNIT				
V <sub>BIASV</sub>	Bias pin voltage	Voltage difference between the Bias voltage and V <sub>CC</sub> after the PCB is plugged in.	-	-	0.5	V			
I <sub>BIASV</sub> Bias pin (I <sub>BIASV</sub> ) input DC current	V <sub>CC</sub> = 0 V, Bias V = 3.6V			1.2	mA				
	DC current	V <sub>CC</sub> = 3.3V, Bias V = 3.6V			10	μΑ			
V <sub>Bn</sub>	Bus voltage during prebias	$\overline{B0} - \overline{B7} = 0$ V, Bias V = 3.3V	1.62		2.1	V			
I <sub>LM</sub>	Fall current during prebias	$\overline{B0} - \overline{B7} = 2V$ , Bias $V = 1.3$ to $2.5V$			1	μΑ			
I <sub>HM</sub>	Rise current during prebias	$\overline{B0} - \overline{B7} = 1$ V, Bias V = 3 to 3.6V	-1			μΑ			
I <sub>Bn</sub> PEAK	Peak bus current during insertion	$V_{CC} = 0$ to 3.3V, $\overline{B0} - \overline{B7} = 0$ to 2.0V, Bias V = 2.7 to 3.6V, OEB0 = 0.8V, $t_r = 2$ ns			10	mA			
1 055	$V_{CC} = 0 \text{ to } 3.3 \text{V, OEB0} = 0.8 \text{V}$				100				
I <sub>OL</sub> OFF	Power up current	V <sub>CC</sub> = 0 to 1.2V, OEB0 = 0 to 5V	100		μΑ				
t <sub>GR</sub>	Input glitch rejection	V <sub>CC</sub> = 3.3V	1.0	1.35		ns			

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

### DC ELECTRICAL CHARACTERISTICS

Over recommended operating free-air temperature range unless otherwise noted.

aal	parameter		toot one distance?		limits		unit
symbol	paramete	er	test conditions <sup>1</sup>	min	typ <sup>2</sup>	max	unit
I <sub>OH</sub>	High level output current	B0 – B7	$V_{CC} = MAX, V_{IL} = MAX, V_{OH} = 1.9V$			100	μΑ
	Davis off autout aumont	B0 – B7	$V_{CC} = 0V$ , $V_{IL} = MAX$ , $V_{OH} = 1.9V$			100	
OFF	Power-off output current	B0 – B7	V <sub>CC</sub> = 0V, V <sub>IL</sub> = MAX, V <sub>OH</sub> = 1.9V@85°C			300	μΑ
.,	High-level output	100 1072	$V_{CC}$ = MIN to MAX; $I_{OH}$ = -100 $\mu$ A	V <sub>CC</sub> -0.2			V
$V_{OH}$	voltage	AO0 – AO7 <sup>3</sup>	$V_{CC} = MIN; I_{OH} = -8mA$	2.4			V
			$V_{CC} = MIN; I_{OH} = -32mA$	2.0			V
		AO0 – AO7 <sup>3</sup>	$V_{CC} = MIN; I_{OL} = 16mA$			0.4	V
V <sub>OL</sub> Low-level output voltage	A00 - A07	$V_{CC} = MIN; I_{OL} = 32mA$			0.5	V	
		<u>B0</u> − <u>B7</u>	$V_{CC} = MIN, I_{OL} = 4mA$	0.5			V
			$V_{CC} = MIN, I_{OL} = 100mA$	0.75 1.0 1.20			
$V_{IK}$	Input clamp voltage		$V_{CC} = MIN$ , $I_I = I_{IK} = -18mA$		-0.85	-1.2	V
		Control pins	$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } 300mV$			±1.0	
I <sub>I</sub>	Input leakage current	Control/ AI0 – AI7	V <sub>CC</sub> = 0V or 3.6V; V <sub>I</sub> = 5.5V			10	μΑ
-		AI0 – AI7	$V_{CC} = 3.6V; V_{I} = V_{CC}$			1	1
		Note 4	V <sub>CC</sub> = 3.6V; V <sub>I</sub> = 300mV			<b>-</b> 5	1
			$V_{CC} = MAX, V_I = 1.9V$			100	μΑ
I <sub>IH</sub>	High-level input current	B0 – B7	$V_{CC} = MAX$ , $V_I = 3.5V$ , note 5	3.5V, note 5 100			<u> </u>
			V <sub>CC</sub> = MAX, V <sub>I</sub> = 3.75V, Note 5 @ -40°C	100			mA
f <sub>IL</sub>	Low-level input current	B0 – B7	$V_{CC} = MAX, V_{I} = 0.75V$			-100	μΑ
I <sub>OZH</sub>	Off-state output current	AO0 – AO7	$V_{CC} = MAX, V_{O} = 3V$			5	μА
I <sub>OZL</sub>	Off-state output current	AO0 – AO7	$V_{CC} = MAX, V_O = 0.5V$			-5	μΑ
I <sub>CCH</sub>	Committee of the tall		V <sub>CC</sub> = MAX, outputs High		14	31	^
I <sub>CCL</sub>	Supply current (total)	$B{\rightarrow}A$	V <sub>CC</sub> = MAX, outputs Low		17	38	mA
I <sub>CCZ</sub>	Supply current		V <sub>CC</sub> = MAX		22	55	mA
I <sub>CCH</sub>	0 1 10 10 10		V <sub>CC</sub> = MAX, outputs High	1	14	32	
I <sub>CCL</sub>	Supply current (total)	$A{ ightarrow}B$	V <sub>CC</sub> = MAX, outputs Low		9	18	mA
I <sub>CCZ</sub>	Supply current		$V_{CC} = MAX$		14	33	mA

#### NOTES:

- 1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operation conditions for the applicable type.
- All typical values are at V<sub>CC</sub> = 3.3V, T<sub>A</sub> = 25°C.
   Due to test equipment limitations, actual test conditions are V<sub>IH</sub> = 1.8V and V<sub>IL</sub> = 1.3V for the B side.
- 4. Unused pins are at V<sub>CC</sub> or GND.
  5. For B port input voltage between 3 and 5 volt; I<sub>IH</sub> will be greater than 100mA but the part will continue to function normally (clamping circuit is active).

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

## AC ELECTRICAL CHARACTERISTICS INDUSTRIAL AND COMMERCIAL (A TO B)

SYMBOL	PARAMETER	TEST CONDITION	MIN	TYP	MAX	MIN	MAX	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, An to Bn through latch		1.2 1.2	2.7 2.6	4.8 4.3	1.0 1.0	5.3 4.9	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, An to Bn transparent latch		1.3 1.8	3.2 3.7	5.2 5.6	1.0 1.6	6.1 6.3	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, LCAB to Bn latch		2.0 2.3	3.8 4.3	5.8 6.3	1.2 1.8	7.0 7.3	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, LCAB to Bn register		2.1 2.0	3.8 4.3	5.7 6.5	1.4 1.8	6.9 7.3	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, SABX to Bn inverting		1.2 2.3	4.3 5.1	7.6 8.0	1.0 2.0	9.2 8.7	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, SABX to Bn non-inverting		1.8 1.8	4.0 5.0	6.4 8.5	1.1 1.6	8.0 9.8	ns
t <sub>PLH</sub> t <sub>PHL</sub>	OEBn to $\overline{\mathbb{B}}$ n		1.5 1.6	3.4 3.4	5.4 5.3	1.0 1.0	6.0 7.2	ns

## AC ELECTRICAL CHARACTERISTICS INDUSTRIAL AND COMMERCIAL (A TO B)

SYMBOL	PARAMETER	TEST CONDITION		+25°C, V <sub>CC</sub> R <sub>L</sub> = 16.5Ω		T <sub>amb</sub> = -40 V <sub>CC</sub> = 3. R <sub>L</sub> =	UNIT	
			MIN	TYP	MAX	MIN	MAX	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, An to Bn through latch		1.2 1.2	2.8 2.4	4.5 4.0	1.0 1.0	5.7 4.6	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, An to Bn transparent latch		1.4 1.7	3.2 3.5	5.1 5.4	1.0 1.3	6.1 5.9	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, LCAB to Bn latch		2.0 2.2	3.8 4.1	5.6 6.1	1.3 1.6	6.9 7.0	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, LCAB to Bn register		2.0 2.2	3.9 4.1	5.9 6.1	1.2 1.6	7.7 7.0	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, SABX to Bn inverting		1.2 1.8	4.6 4.7	8.6 7.9	1.0 1.6	10.4 8.7	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, SABX to Bn non-inverting		1.3 1.5	4.5 4.6	8.2 8.2	1.0 1.2	10.0 9.1	ns
t <sub>PLH</sub> t <sub>PHL</sub>	OEBn to Bn		1.5 1.5	3.4 3.2	6.0 7.2	1.0 1.0	6.3 7.0	ns

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

## AC ELECTRICAL CHARACTERISTICS INDUSTRIAL AND COMMERCIAL (B TO A)

SYMBOL	PARAMETER	TEST CONDITION	T <sub>amb</sub> =	+25°C, V <sub>CC</sub>	= 3.3V	$T_{amb} = -40$ $V_{CC} = 3$ .	UNIT	
			MIN	TYP	MAX	MIN	MAX	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, Bn to An through mode		2.5 3.0	4.5 5.1	6.5 7.3	1.6 2.6	7.8 9.1	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, Bn to An transparent latch		3.4 3.2	5.4 5.4	7.6 7.6	2.2 2.7	9.2 9.3	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, LCAB to An latch		2.1 1.6	3.9 3.3	5.8 5.0	1.3 1.2	7.2 5.9	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, LCAB to An register		1.9 2.3	3.7 4.1	5.7 6.0	1.1 1.8	6.8 7.0	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, SABX to An inverting		2.3 2.5	4.2 4.5	6.4 6.5	1.3 2.0	7.9 7.4	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, SABX to An non-inverting		1.4 1.9	3.9 4.0	8.7 6.1	1.0 1.5	9.8 7.1	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, Aln to AOn loopback		2.4 2.3	4.3 4.4	6.3 6.6	1.6 1.6	8.1 7.6	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay, LPBK to An non-inverting or inverting		2.0 1.3	4.3 4.9	7.0 9.4	1.4 1.5	8.9 11.3	ns
t <sub>PZH</sub> t <sub>PHZ</sub>	Propagation delay, OEA to An		2.4 3.1	4.3 5.3	6.3 7.6	1.9 2.5	7.3 8.9	ns
t <sub>PZH</sub> t <sub>PHZ</sub>	Propagation delay, OEA to An		2.1 1.4	4.0 2.7	6.2 4.4	1.7 1.0	6.9 5.2	ns

# 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

### AC SETUP REQUIREMENTS INDUSTRIAL AND COMMERCIAL

				LIMITS	
SYMBOL	PARAMETER	TEST CONDITION	T <sub>amb</sub> = +25°C, V <sub>CC</sub> = 3.3V	T <sub>amb</sub> = -40 to +85°C, V <sub>CC</sub> = 3.3V±10%	UNIT
		CONDITION		le) / $C_D$ = 30pF (B side) de) / $R_U$ = $9\Omega$ (B side)	
			MIN	MIN	
t <sub>S</sub> (H) t <sub>S</sub> (L)	Setup time Aln to LCAB or Bn to LCBA		3.0 3.0	4.0 4.0	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (latch mode) Aln to LCAB		6.0 5.0	6.5 5.5	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (register mode) Aln to LCAB		1.0 1.0	1.3 1.3	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (latch mode) Bn to LCAB		1.5 1.5	2.0 2.0	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (register mode) Bn to LCAB		1.0 1.0	1.3 1.3	ns
t <sub>w</sub> (H) t <sub>w</sub> (L)	Pulse width, High or Low Aln to LCAB or Bn to LCBA		3.0 3.0	4.0 4.0	ns

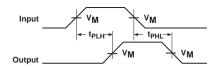
### AC SETUP REQUIREMENTS INDUSTRIAL AND COMMERCIAL

				LIMITS	
SYMBOL	PARAMETER	TEST	T <sub>amb</sub> = +25°C, V <sub>CC</sub> = 3.3V	$T_{amb}$ = -40 to +85°C, $V_{CC}$ = 3.3V±10%	UNIT
		CONDITION		le) / $C_D$ = 30pF (B side) e) / $R_U$ = 16.5 $\Omega$ (B side)	
			MIN	MIN	
t <sub>S</sub> (H) t <sub>S</sub> (L)	Setup time Aln to LCAB or Bn to LCBA		3.0 3.0	4.0 4.0	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (latch mode) Aln to LCAB		6.0 5.0	6.5 5.5	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (register mode) Aln to LCAB		1.0 1.0	1.3 1.3	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (latch mode) Bn to LCAB		1.5 1.5	2.0 2.0	ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time (register mode) Bn to LCAB		1.0 1.0	1.3 1.3	ns
t <sub>w</sub> (H) t <sub>w</sub> (L)	Pulse width, High or Low Aln to LCAB or Bn to LCBA		3.0 3.0	4.0 4.0	ns

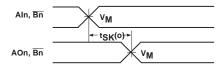
## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

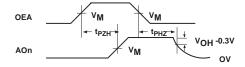
### **AC WAVEFORMS**



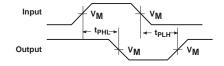
Waveform 1. Propagation Delay for Data or Output Enable to Output



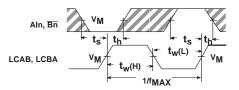
Waveform 3. Output to Output Skew



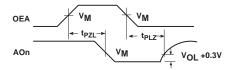
Waveform 5. 3-State Output Enable Time to High Level and Output Disable Time from High Level



Waveform 2. Propagation Delay for Data or Output Enable to Output



Waveform 4. Setup and Hold Times, Pulse Widths and Maximum Frequency



Waveform 6. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

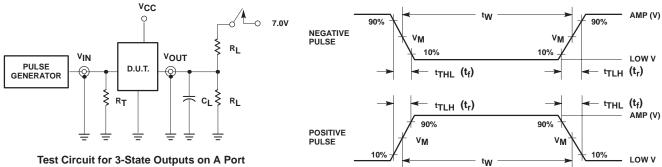
NOTE: The shaded areas indicate when the input is permitted to change for predictable output performance.

SG00070

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

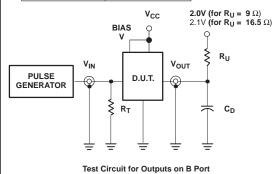
FBL2033

### **TEST CIRCUIT AND WAVEFORMS**



### **SWITCH POSITION**

TEST	SWITCH
t <sub>PLZ,</sub> t <sub>PZL</sub>	closed
All other	open



 $V_{M} = 1.55V$  for  $\overline{Bn}$ ,  $V_{M} = 1.5V$  for all others. **Input Pulse Definitions** 

Family	INPUT PULSE REQUIREMENTS							
FB+	Amplitude	Low V	Rep. Rate	t <sub>W</sub>	t <sub>TLH</sub>	t <sub>THL</sub>		
A Port	3.0V	0.0V	1MHz	500ns	2.5ns	2.5ns		
B Port	2.0V	1.0V	1MHz	500ns	2.0ns	2.0ns		

#### **DEFINITIONS:**

R<sub>L</sub> = Load Resistor; see AC CHARACTERISTICS for value.

Load capacitance includes jig and probe capacitance; see AC

CHARACTERISTICS for value.

Termination resistance should be equal to Z<sub>OUT</sub> of pulse generators.

Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value.

Pull up resistor; see AC CHARACTERISTICS for value.

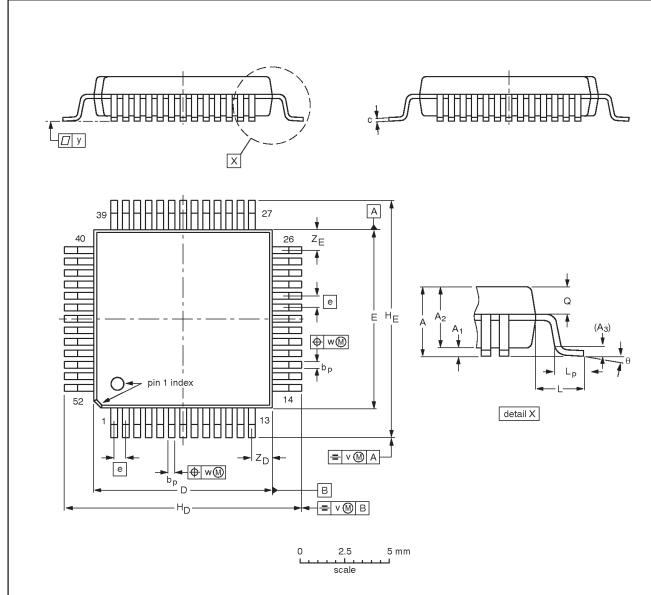
SG00063

## 3.3V BTL 8-bit latched/registered/pass-thru Futurebus+ universal interface transceiver

FBL2033

QFP52: plastic quad flat package; 52 leads (lead length 1.6 mm); body 10 x 10 x 2.0 mm

SOT379-1



### DIMENSIONS (mm are the original dimensions)

UNIT	A max.	Α1	A <sub>2</sub>	Α3	bp	O	D <sup>(1)</sup>	E <sup>(1)</sup>	e	H <sub>D</sub>	HE	L	Lp	Q	٧	w	у	Z <sub>D</sub> <sup>(1)</sup>	Z <sub>E</sub> <sup>(1)</sup>	θ
mm	2.45	0.45 0.25	2.10 1.95	0.25	0.38 0.22	0.23 0.13	10.1 9.9	10.1 9.9	0.65	13.45 12.95	13.45 12.95	1.60	0.95 0.65	1.05 0.90	0.20	0.12	0.10	1.24 0.95	1.24 0.95	7° 0°

#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT379-1		MO-108			95-02-04	

## 3.3V BTL 8-bit latched/registered/pass-thru universal transceiver

FBL2033

#### Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

<sup>[1]</sup> Please consult the most recently issued datasheet before initiating or completing a design.

#### Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

**Application information** — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

#### **Disclaimers**

**Life support** — These products are not designed for use in life support appliances, devices or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes, without notice, in the products, including circuits, standard cells, and/or software, described or contained herein in order to improve design and/or performance. Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

Philips Semiconductors 811 East Arques Avenue P.O. Box 3409 Sunnyvale, California 94088–3409 Telephone 800-234-7381 © Copyright Philips Electronics North America Corporation 1998 All rights reserved. Printed in U.S.A.

print code Date of release: 07-98

Document order number: 9397-750-05517

Let's make things better.

Philips Semiconductors



